Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/600,581	HANNA, MICHELLE M.
Examiner	Art Unit
Young J. Kim	1637

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
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Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	12/4/2007	YJK
see enclosed for text-search strategy		
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